Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10616067	YANO ET AL.

Art Unit

Examiner

Foud, Hicham B 2616

SEARCHED

Class	Subclass	Date	Examiner	
370	332	6/2/2008	HF	
370	333	6/2/2008	HF	
455	522	6/2/2008	HF	

SEARCH NOTES

Search Notes	Date	Examiner
UPDATE EAST SEARCH	6/2/2008	HF
Google	6/2/2008	HF

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No. :